

<b>Notice of References Cited</b>	Application/Control No. 09/844,986	Applicant(s)/Patent Under Reexamination JAWOSIUK ET AL.	
	Examiner Rita J. Desai	Art Unit 1625	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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X	B	US-6,117,276	09-2000	Cunkle et al.	203/8
X	C	US-5,254,760	10-1993	Winter et al.	585/5
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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